

ICCHIBAN 8: Czech results obtained with thermoluminescent and track etched detectors

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ICCHIBAN - protocol

Ion	Energy (MeV/n)	Range in H ₂ O (cm)	LET _∞ H ₂ O (keV/μm)
⁴ He	150	15.6	2.2
¹⁶ O	400	20.2	19.8
⁴⁰ Ar	500	14.44	89.31
⁵⁶ Fe	200	2.1	309.7

Exposure	Dose/Fluence	Condition
1	50 mGy	Bare Beam for TLD/OSL Efficiency
2	50 mGy	Behind PMMA ¹⁾ Absorber for TLD/OSL
3	5000 cm ⁻²	Bare Beam for CR-39 PNTD calibration ²⁾
4	5000 cm ⁻²	Behind PMMA Absorber for CR-39 PNTD ²⁾

1) Absorber thickness in H₂O equivalent: 11.47; 10.01; 5.25; and. 0.345 cm for He; O; Ar; and Fe.

2) Higher doses used for 150 MeV/n ⁴He exposures.

Thermoluminescent detectors (TLD's)

$\text{Al}_2\text{O}_3:\text{C}$:

- $H^*(10) \geq 1 \mu\text{Sv}$
- rapid decrease of light conversion factor (relative response RR) with LET above $\sim 1 \text{ keV}/\mu\text{m}$

Czech alumophosphate (AIP) TL glass

- $H^*(10) \geq 10 \mu\text{Sv}$
- slower decrease of relative response RR with LET above $\sim 10 \text{ keV}/\mu\text{m}$

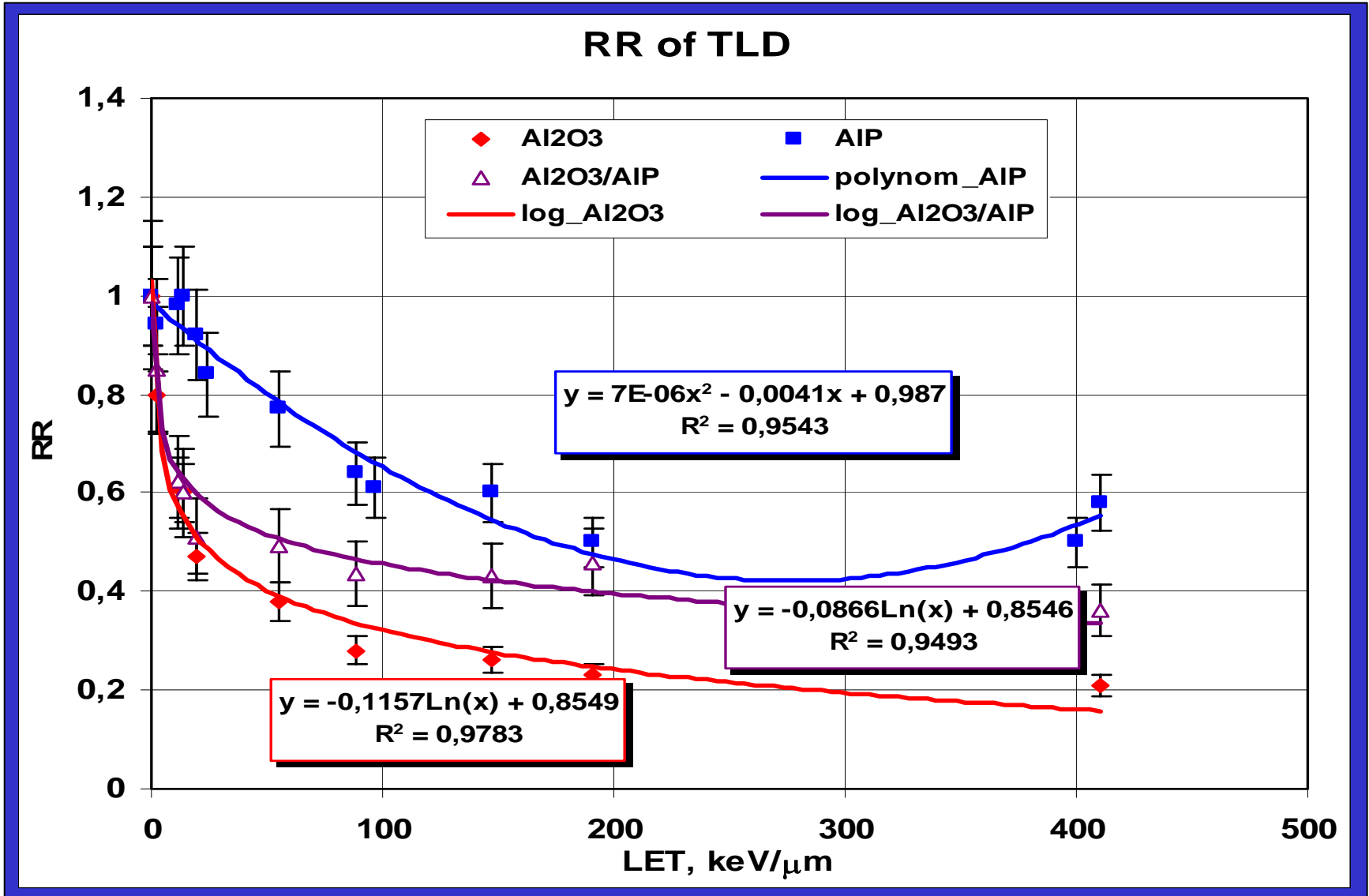
$\text{CaSO}_4:\text{Dy}$ from INRNE BAS

- $H^*(10) \geq 1 \mu\text{Sv}$
- slower decrease of relative response RR with LET above $\sim 10 \text{ keV}/\mu\text{m}$

Comparison of relative responses obtained during ICCHIBAN 8 experiment

Beam	Actual energy	Actual LET		RR for	
	MeV/n	keV/ μm	Al ₂ O ₃ :C	Al-P glass	CaSO ₄ :Dy
He	150	2.16	0.77±0.05	0.94±0.08	1.01±0.09
He/PMMA	61 ¹⁾	4.2	1.10±0.08	1.37±0.11	1.63±0.12
O	395	20.0	0.47±0.04	0.92±0.07	0.95±0.06
O/PMMA	268 ¹⁾	25.0	0.47±0.04	0.92±0.08	0.94±0.07
Ar	440	92	0.32±0.02	0.64±0.05	0.59±0.04
Ar/PMMA	377 ¹⁾	108	0.34±0.03	0.68±0.05	0.62±0.04
Fe	130	411	0.25±0.02	0.58±0.04	0.44±0.03
Fe/PMMA	105 ¹⁾	445	0.35±0.03	0.77±0.05	0.57±0.04

LET dependence of the TL relative response (RR)



LET spectrometer based on chemically etched PADC TED

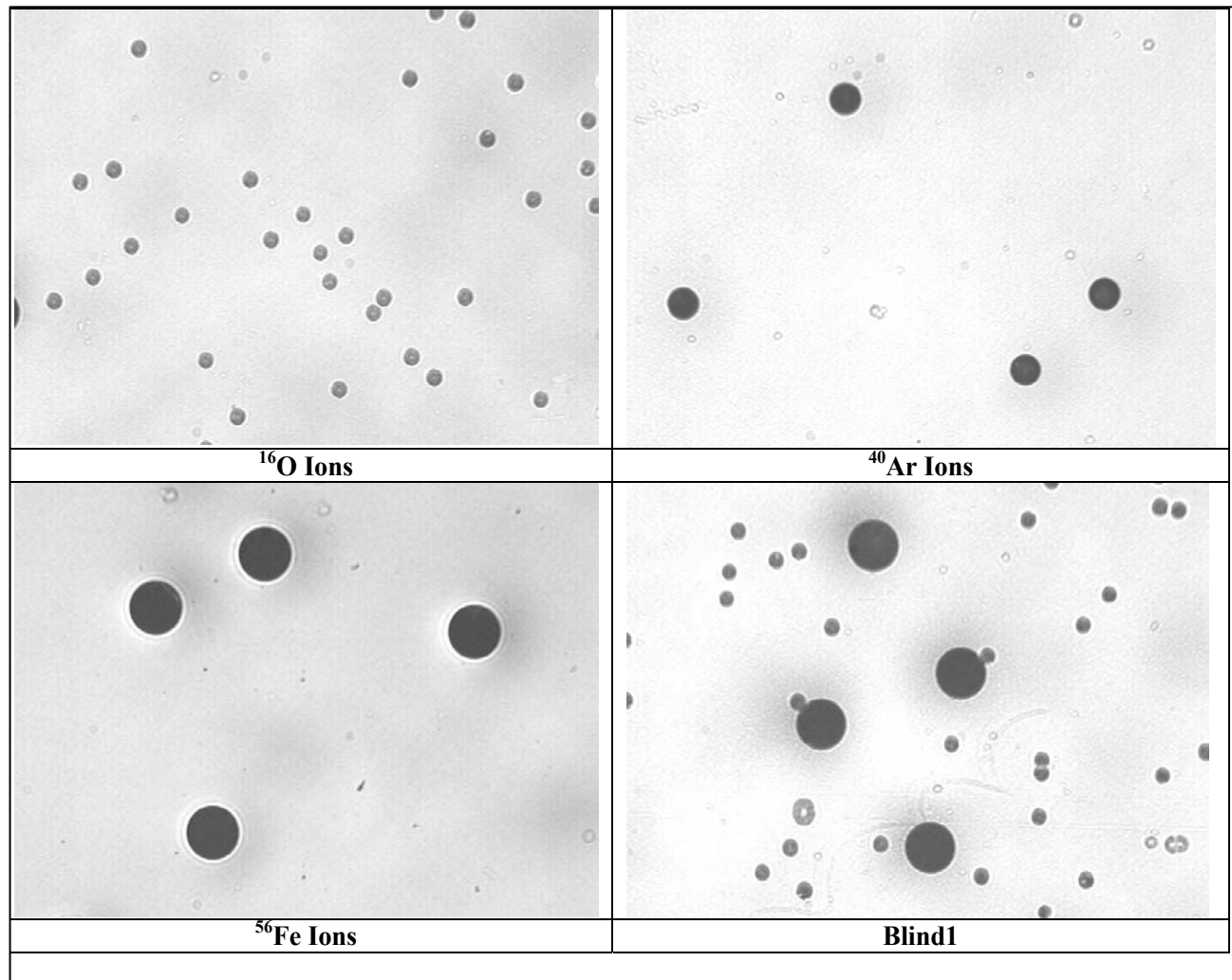
TED - polyallyldiglycolcarbonate (PADC): Page(0.5mm), Tastrak (0.5 and 1 mm);

Etching - 5 N NaOH, 70°C;18 h, $\Delta h \approx 17 \mu\text{m}$;

To determine **LET** - etching rate ratio $V=V_T/V_B$ established through the determination of track parameters;

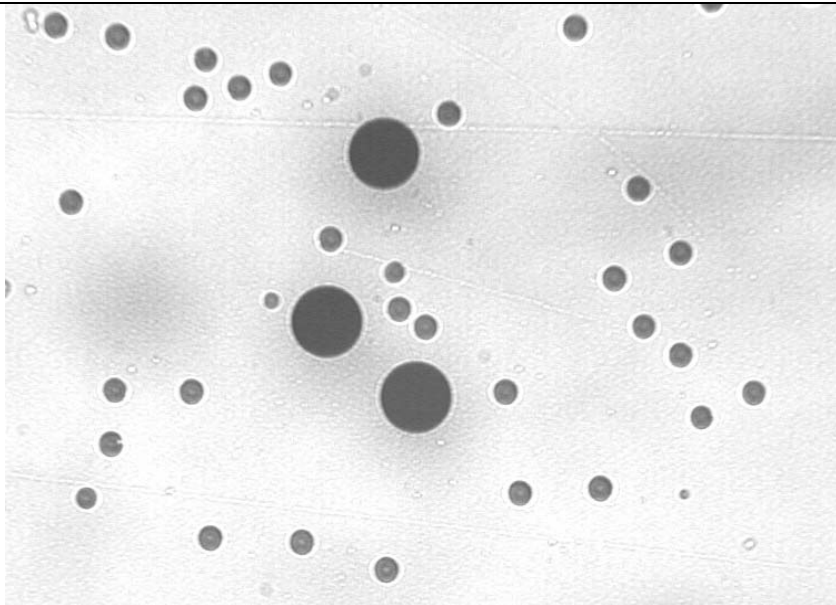
Material	LET range keV/ μm	Range of H mSv
Page, 0.5 mm thick	7 – 700	1 - 100
Tastrak, 0.5 mm thick	15 – 700	
Tastrak, 1 mm thick	22 – 700	

Pictures of tracks etched in Page PADC LET spectrometer and some of exposures - 1

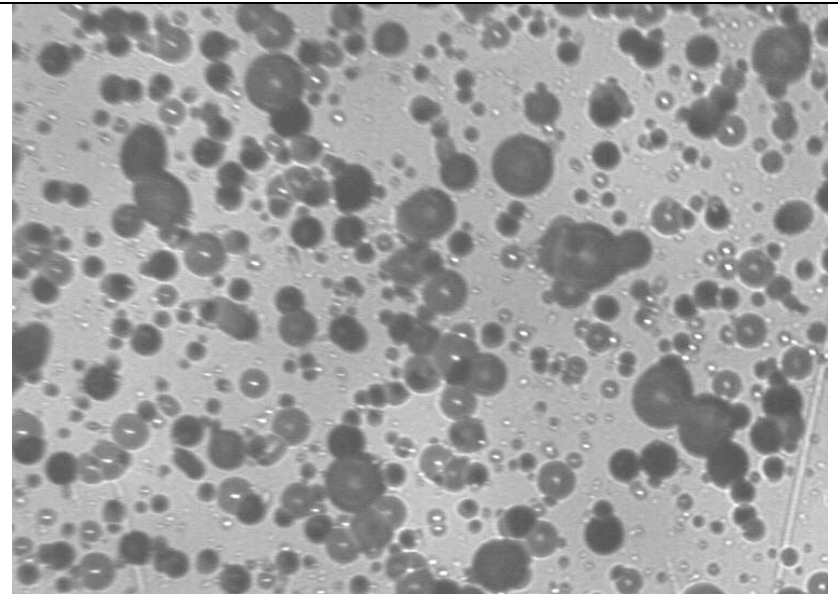


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Pictures of tracks etched in Page PADC LET spectrometer and some of exposures - 2

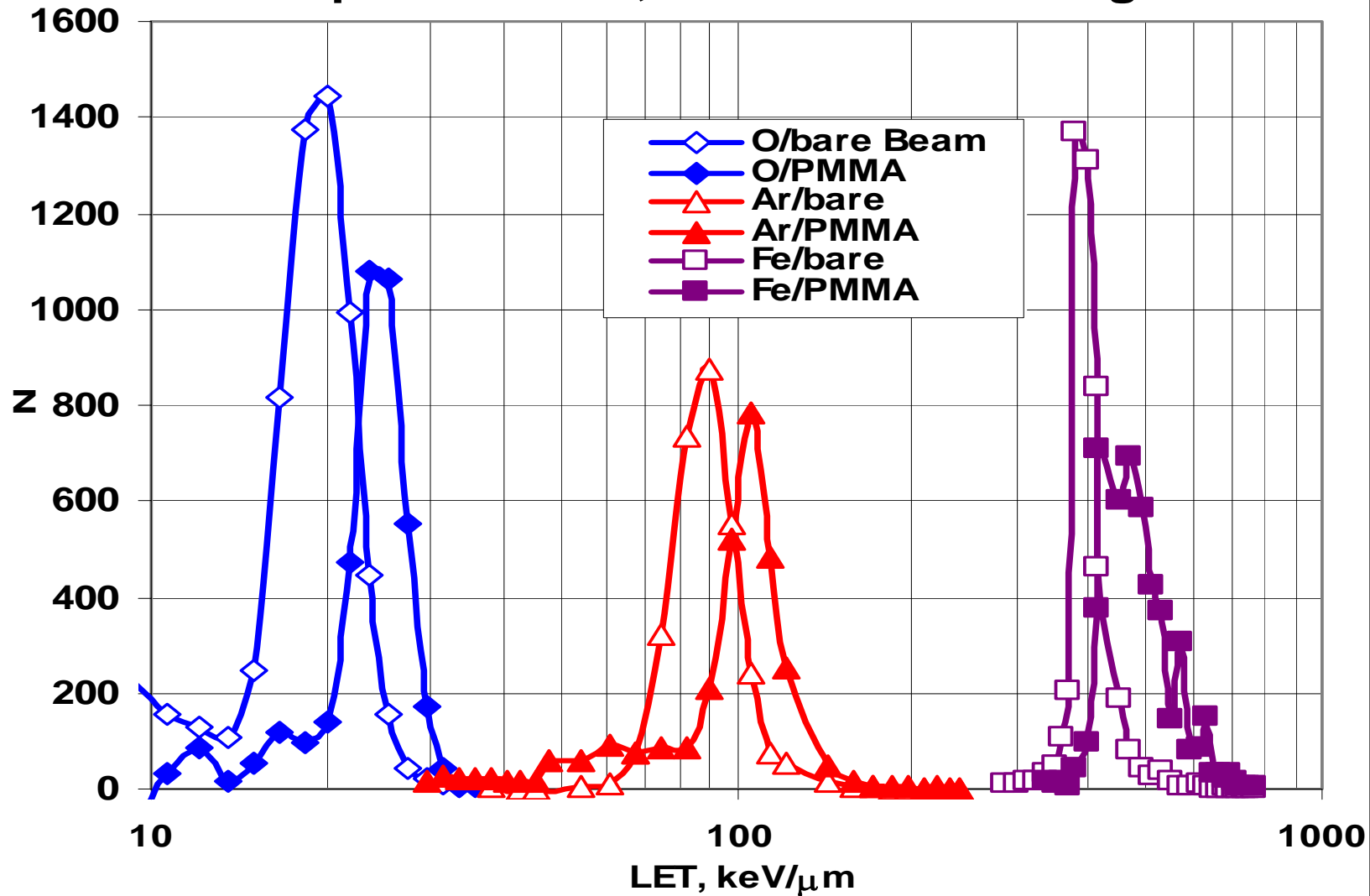


Blind2



Blind3

LET spectra of ^{16}O , ^{40}Ar and ^{56}Fe in Page

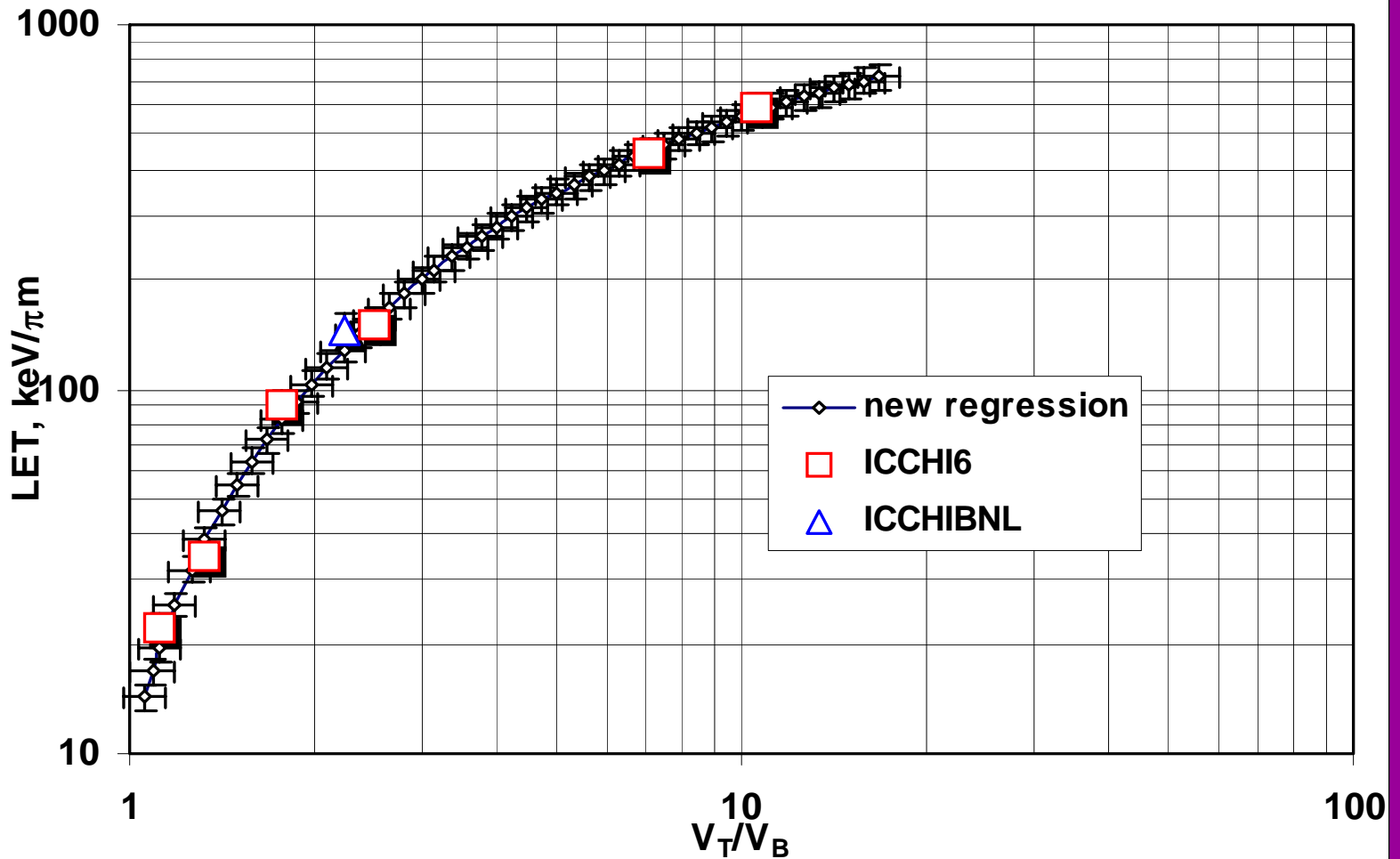


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Average values of ratio $V (= V_T/V_B)$ for PADC materials used for LET spectrometry

Ion	LET in water	Page	V_T/V_B for	
	keV/ μm		Tastrak 0,5 mm	Tastrak 1 mm
O	20.0	1.24±0.02	1.06±0.02	1.10±0.03
O/PMMA	25.0	1.29±0.02	1.12±0.02	1.20±0.03
Ar	92	1.78±0.03	1.78±0.08	1.82±0.06
Ar/PMMA	108	1.89±0.03	2.01±0.03	2.00±0.06
Fe	420	5.50±0.35	7.20±0.20	6.00±0.36
Fe/PMMA	460	7.33±0.73	10.3±0.4	10.0±0.45

Calibration curve Tastrak 0.5 mm



Comparison of LET values (ICCHIBAN 8) with those from regressions (ICCHIBAN 2,4,6,BNL).

Ion	LET _{water} keV/μm	LET, keV/μm, for			
		Page 0.5 mm		Tastrak 0.5 mm	
		ICCHI 8	regressed	ICCHI 8	regressed
O	20.0	20.0	20.9±2.2	14.8	14.5±1.7
O/PMMA	25.0	24.8	24.7±2.6	25.7	20.8±1.8
Ar	92	87.0	86.7±9.0	84.5	83.0±8.0
Ar/PMMA	108	103	102±13	105	106±10
Fe	420	397	396±17	424	420±24
Fe/PMMA	460	457	463±24	490	540±33

Registration efficiencies - ICCHIBAN 8, known exposures

Ion	Shield	Page	Tastrak 0.5	Tastrak 1.0	Average
O	bare	0.78	0.82	-	0.80±0.03
	PMMA	0.52	0.44	-	
Ar	bare	0.44	0.44	0.58	0.49±0.08
	PMMA	0.44	0.33	0.36	
Fe	bare	0.70	0.68	0.62	0.66±0.04
	PMMA	0.70	0.54	0.58	

Dose characteristics calculated from LET spectra

Absorbed dose

$$D_{LET} = \Sigma (dN/dL) * L * dL$$

Dose Equivalent

$$H_{LET} = \Sigma D_{LET} * Q(L)$$

Quality Factor

$$Q = (H_{LET} + D_{pic}) / D_{tot}$$

Where:

L: Value of LET

dN/dL: number of tracks in LET interval dL;

Q(L): quality factors from ICRP-60 recommendations;

D_{LET}: absorbed dose calculated from high LET part of spectra

H_{LET}: dose equivalent calculated from high LET part of spectra

D_{tot}: total absorbed dose

D_{pic}: proton ionisation dose

Registration of secondary particles in He-ion beam with LET spectrometry

Dose D (mGy)	Beam	Registration efficiency tracks per ^4He	Dose due to secondary particles D_{sp} , mGy	D_{sp}/D %
Page	bare	$(3.4 \pm 0.3) \times 10^{-3}$	1.31 ± 0.12	2.6 ± 0.3
	under PMMA	$(11.3 \pm 2.3) \times 10^{-3}$	5.00 ± 0.65	10.0 ± 1.3
Tastrak 0.5 mm	bare	$(1.5 \pm 0.5) \times 10^{-3}$	0.99 ± 0.25	2.0 ± 0.5
	under PMMA	$(11.1 \pm 0.2) \times 10^{-3}$	6.4 ± 1.1	12.8 ± 2.2

Response of Melinex TED in contact with spallation radiators in He - ion beam

Radiator	Beam	Track density behind a radiator, cm^{-2}	
		for D=1 Gy	Per 1 particle
^{197}Au	bare	$312 \pm 104^{*})$	1.1E -06
	PMMA	332 ± 108	1.2E-06
^{209}Bi	bare	840 ± 180	2.9E-06
	PMMA	1210 ± 210	4.2E-06

Blind exposures - Dose estimation based on TLD

Blind No.	Direct readings, mGy		Average LET _{app}	Corrected readings, mGy		Average value of dose in water
	AlP glass	Al ₂ O ₃ :C	keV/μm	AlP glass	Al ₂ O ₃ :C	mGy
1	9.29 ^{*)}	6.75	4.4	9.58	9.87	9.72
2	24.7	16.7	7.8	25.8	27.1	26.5
3	236.6	124.0	46	295.1	300.2	297.6
4	17.7	16.3	0.45	17.9	17.2	17.4
5	17.0	10.0	22	19.0	20.2	19.6
6	17.1	13.0	2.6	17.5	17.5	17.5

***) 1s relative of read values about ± 5%,
uncertainty of corrected procedure estimated to 15%**

Blind exposures -ICCHIBAN 4 - TLD

Blind No.	Particle	D _{H2O} refer.	D _{H2O} - TLD ¹⁾				
			Read		Corrected		Average
			Al ₂ O ₃ :C	AIP	Al ₂ O ₃ :C	AIP	
1	γ	25	28.6	25.3	23.6	25.8	24.7
2	γ	25	30.8	26.4	23.9	26.9	25.4
3	He	25	18.7	25.3	24.9	25.8	25.4
4	γ, He, C, Ne, Fe	12	10.5	12.4	12.1	12.7	12.4
5	γ, He, C, Ne, Fe	10	5.47	10.0	10.3	10.5	10.4
6	C, Ne, Fe	0.39 ²⁾	0.34	1.50	2.27	2.50	2.38
7	Fe/5 g Al	1.0 ³⁾	0.59	2.01	2.57	2.68	2.62
8	C	25	17.2	24.3	25.3	25.1	25.2

¹⁾Relative uncertainty (1s) of direct readings $\pm 5\%$,
for corrected values estimated as $\pm 15\%$.

²⁾ only for heavy charged particles ³⁾ In front of Al – absorber

Blind exposures -ICCHIBAN 4 - LET TED

Blind No.	D _{H2O} , mGy from							
	C		Ne		Fe		Total	
	ref.	TED	ref.	TED	ref.	TED	ref.	TED
3 ¹⁾	~ 0	~ 0	~ 0	~ 0	~ 0	~ 0	25	22 ± 5 ²⁾
4	0.018	0.015±0.002	0.050	0.031±0.004	0.325	0.31±0.04	0.39	0.32±0.04
5	2	1.7±0.2	2	1.8±0.2	2	2.0±0.2	6.0	5.5±0.4
6	0.018	0.014±0.002	0.050	0.042±0.006	0.325	0.32±0.03	0.39	0.38±0.03
7	-	-	-	-	1 ³⁾	1.2±0.2	1.0	1.2±0.2
8	25	≥ 22	-	-	-	-	25	≥ 22

1) Irradiated by He-ions, dose estimation by TED based on the secondary charged particles created by nuclear reactions of primary ions;

2) here and for other uncertainties - 1 s; 3) Behind 5 g/cm² of Al.

Blind exposures - Dose estimation based on TED (above ~ 10 keV/ μm)

The results of evaluations and analysis of the LET spectra showed that:

- Blinds 1 and 2 - two of directly registered ions used (see images);
- Blind No. 3 overirradiated (see image) - probably exposed to at least three from used ions.
- Blind No. 4 – no heavier CP
- Blinds Nos. 5 and 6 exposed, exposure level rather low.

Dose characteristics calculated from LET spectra

Absorbed dose

$$D_{LET} = \Sigma (dN/dL) * L * dL$$

Dose Equivalent

$$H_{LET} = \Sigma D_{LET} * Q(L)$$

Quality Factor

$$Q = (H_{LET} + D_{pic}) / D_{tot}$$

Where:

L: Value of LET

dN/dL: number of tracks in LET interval dL;

Q(L): quality factors from ICRP-60 recommendations;

D_{LET}: absorbed dose calculated from high LET part of spectra

H_{LET}: dose equivalent calculated from high LET part of spectra

D_{tot}: total absorbed dose

D_{pic}: proton ionisation dose

Blind doses due to the particles registered with PADC-LET spectrometer

Blind No.	PADC	D, mGy	
		individual	average
1	Page	2.02±0.20	1.98±0.21
	T0.5	1.88±0.19	
	T1.0	2.04±0.21	
2	Page	1.48±0.16	1.42±0.15
	T0.5	1.39±0.15	
	T1.0	1.41±0.15	
5	Page	4.41±0.66	4.28±0.92
	T0.5	4.14±0.63	
	T1.0	-	
6	Page	3.58±0.59	3.84±0.84
	T0.5	4.10±0.48	
	T1.0	-	

Blind exposures - summary

Blind No.	TLD “aver.LET _{app} ” keV/μm	D _{total} – TLD’s results mGy	Dose ≥ 10keV/μm mGy
1	4.4	9.7±1.5	1.98±0.21
2	7.8	26.5±4.0	1.42±0.15
3	46	298±45	?
4	0.45	17.4±2.6	~ 0
5	22	19.6±2.9	4.28±0.92
6	2.6	17.5±2.6	3.84±0.84

Conclusions

1. The participation at ICCHIBAN 8 helped us again to improve substantially the evaluation procedures and the interpretation of read data. We consider the results obtained as satisfactory.
2. The experience acquired in all ICCHIBANs will permit us to compose detector's sets for other studies in space and on the Earth's in still more optimal way.
3. Going-on activities related:
 - Passive detectors inside MATRJOSHKA-R (12/05-09/06); further exposure since 12/06
 - CERN - ICCHIBAN runs with passive detectors
 - Nuclotron JINR calibrations

Acknowledgements

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Thank you for your attention !